LDO Linear Regulators - Micropower, DELAY, Adjustable RESET, and Monitor FLAG

150 mA

NCV8502 Series

The NCV8502 is a family of precision micropower voltage regulators. Their output current capability is 150 mA. The family has output voltage options for adjustable, 2.5 V, 3.3 V, 5.0 V, 8.0 V, and 10 V.

The output voltage is accurate within $\pm 2.0\%$ with a maximum dropout voltage of 0.6 V at 150 mA. Low quiescent current is a feature drawing only 90 μ A with a 100 μ A load. This part is ideal for any and all battery operated microprocessor equipment.

Microprocessor control logic includes an active \overline{RESET} (with DELAY), and a FLAG monitor which can be used to provide an early warning signal to the microprocessor of a potential impending \overline{RESET} signal. The use of the FLAG monitor allows the microprocessor to finish any signal processing before the \overline{RESET} shuts the microprocessor down.

The active \overline{RESET} circuit operates correctly at an output voltage as low as 1.0 V. The \overline{RESET} function is activated during the power up sequence or during normal operation if the output voltage drops outside the regulation limits.

The reset threshold voltage can be decreased by the connection of external resistor divider to R_{ADJ} lead.

The regulator is protected against reverse battery, short circuit, and thermal overload conditions. The device can withstand load dump transients making it suitable for use in automotive environments. The device has also been optimized for EMC conditions.

Features

- Output Voltage Options: Adjustable, 2.5 V, 3.3 V, 5.0 V, 8.0 V, 10 V
- ±2.0% Output
- Low 90 µA Quiescent Current
- Fixed or Adjustable Output Voltage
- Active RESET
- Adjustable Reset
- 150 mA Output Current Capability
- Fault Protection
 - ♦ +60 V Peak Transient Voltage
 - → -15 V Reverse Voltage
 - Short Circuit
 - Thermal Overload

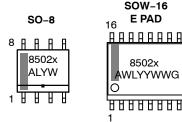


SO-8 D SUFFIX CASE 751



SOIC 16 LEAD WIDE BODY EXPOSED PAD PDW SUFFIX CASE 751AG

MARKING DIAGRAMS



= Voltage Ratings as Indicated Below:

A = Adjustable

2 = 2.5 V

3 = 3.3 V

5 = 5.0 V

8 = 8.0 V0 = 10 V

A = Assembly Location

WL, L = Wafer Lot

YY, Y = Year

WW, W = Work Week

G or ■ = Pb-Free Device

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 12 of this data sheet.

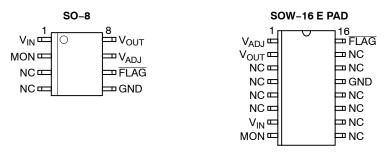
NOTE: Some of the devices on this data sheet have been **DISCONTINUED**. Please refer to the table on page 12.

- Early Warning through FLAG/MON Leads
- NCV Prefix for Automotive and Other Applications Requiring Site and Change Control
- AEC Qualified
- PPAP Capable

1

These are Pb–Free Devices

PIN CONNECTIONS, ADJUSTABLE OUTPUT



PIN CONNECTIONS, FIXED OUTPUT

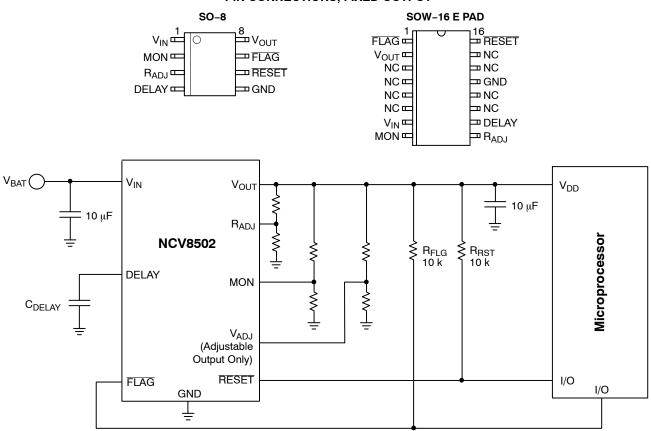


Figure 1. Application Diagram

MAXIMUM RATINGS*

| Rating | Value | Unit |
|--|------------|------|
| V _{IN} (dc) | –15 to 48 | V |
| Peak Transient Voltage (46 V Load Dump @ V _{IN} = 14 V) | 60 | ٧ |
| Operating Voltage | 45 | V |
| V _{OUT} (dc) | -0.3 to 16 | V |
| Voltage Range (RESET, FLAG) | -0.3 to 10 | V |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

^{*}During the voltage range which exceeds the maximum tested voltage of V_{IN}, operation is assured, but not specified. Wider limits may apply. Thermal dissipation must be observed closely.

MAXIMUM RATINGS* (continued)

| Rating | Symbol | Value | Unit |
|---|--|----------------|----------------------|
| Input Voltage Range (MON, V _{ADJ} , R _{ADJ}) | | -0.3 to 10 | V |
| ESD Susceptibility (Human Body Model) | | 2.0 | kV |
| Junction Temperature | TJ | -40 to +150 | °C |
| Storage Temperature | T _S | -55 to 150 | °C |
| Package Thermal Resistance, SO-8: Junction-to-Case Junction-to-Ambient | $R_{	hetaJC} \ R_{	hetaJA}$ | 45 165 | °C/W °C/W |
| Package Thermal Resistance, SOW-16 E PAD: Junction-to-Case Junction-to-Ambient Junction-to-Pin (Note 1) | $egin{array}{c} R_{	hetaJC} \ R_{	hetaJA} \ R_{	hetaJP} \end{array}$ | 15 56 35 | °C/W °C/W °C/W |
| Lead Temperature Soldering: SMD style only, Reflow (Note 2) Pb-Free Part 60 - 150 sec above 217°C, 40 sec max at peak | SLD | 265 peak | °C |

$\textbf{ELECTRICAL CHARACTERISTICS} \text{ ($I_{OUT} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = $dependent on voltage option (Note 3)$; unless $I_{OUT} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = $dependent on voltage option (Note 3)$; unless $I_{OUT} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq T_{J} \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C \leq 150^{\circ}C$; $V_{IN} = 1.0 \text{ mA, } -40^{\circ}C$; $V_{IN} = 1.0 \text{ mA,$ otherwise specified.)

| Characteristic Test Conditions | | Min | Тур | Max | Unit |
|---|--|-------|-------|-------|------|
| Output Stage | | | | | |
| Output Voltage for 2.5 V Option | $6.5 \text{ V} < \text{V}_{\text{IN}} < 16 \text{ V}, 100 \mu\text{A} \le \text{I}_{\text{OUT}} \le 150 \text{ mA}$ | 2.450 | 2.5 | 2.550 | V |
| | 5.5 V < V_{IN} < 26 V , 100 μA \leq I _{OUT} \leq 150 mA | 2.425 | 2.5 | 2.575 | V |
| Output Voltage for 3.3 V Option | $7.3 \text{ V} < \text{V}_{\text{IN}} < 16 \text{ V}, 100 \mu\text{A} \le \text{I}_{\text{OUT}} \le 150 \text{ mA}$ | 3.234 | 3.3 | 3.366 | V |
| | 5.5 V < V_{IN} < 26 V , 100 μ A \leq I _{OUT} \leq 150 mA | 3.201 | 3.3 | 3.399 | V |
| Output Voltage for 5.0 V Option | $9.0 \text{ V} < \text{V}_{\text{IN}} < 16 \text{ V}, 100 \mu\text{A} \le \text{I}_{\text{OUT}} \le 150 \text{ mA}$ | 4.90 | 5.0 | 5.10 | V |
| | 6.0 V < V_{IN} < 26 V , 100 μ A \leq I _{OUT} \leq 150 mA | 4.85 | 5.0 | 5.15 | V |
| Output Voltage for 8.0 V Option | 9.0 V < V_{IN} < 26 V , 100 μA ≤ I _{OUT} ≤ 150 mA | 7.76 | 8.0 | 8.24 | V |
| Output Voltage for 10 V Option | 11 V < V_{IN} < 26 V , 100 μA ≤ I _{OUT} ≤ 150 mA | 9.7 | 10 | 10.3 | V |
| | | | | | V |
| Output Voltage for Adjustable | V _{OUT} = V _{ADJ} (Unity Gain) | | | | |
| Option | $6.5 \text{ V} < \text{V}_{\text{IN}} < 16 \text{ V}, 100 \mu\text{A} < \text{I}_{\text{OUT}} < 150 \text{mA}$ | 1.254 | 1.280 | 1.306 | V |
| | 5.5 V < V _{IN} < 26 V, 100 μA < I _{OUT} < 150 mA | 1.242 | 1.280 | 1.318 | V |
| Dropout Voltage (V _{IN} - V _{OUT}) | I _{OUT} = 150 mA | - | 400 | 600 | mV |
| (5.0 V, 8.0 V, 10 V and Adj. > 5.0 V Options Only) | I _{OUT} = 1.0 mA | _ | 100 | 150 | mV |
| Load Regulation | V _{IN} = 14 V, 5.0 mA ≤ I _{OUT} ≤ 150 mA | -30 | 5.0 | 30 | mV |
| Line Regulation | [V _{OUT} (Typ) + 1.0] < V _{IN} < 26 V, I _{OUT} = 1.0 mA | - | 15 | 60 | mV |
| Quiescent Current, Low Load | I_{OUT} = 100 μ A, V_{IN} = 12 V, MON = V_{OUT} | | | | |
| 2.5 V Option | | _ | 90 | 125 | μΑ |
| 3.3 V Option 5.0 V Option | | _ | 90 | 125 | μΑ |
| 8.0 V Option | | - | 90 | 125 | μΑ |
| 10 V Option | | _ | 100 | 150 | μΑ |
| Adjustable Option | | _ | 100 | 150 | μΑ |
| | | _ | 50 | 75 | μΑ |
| Quiescent Current, Medium Load All Options | I_{OUT} = 75 mA, V_{IN} = 14 V, MON = V_{OUT} | _ | 4.0 | 6.0 | mA |
| Quiescent Current, High Load All Options | I _{OUT} = 150 mA, V _{IN} = 14 V, MON = V _{OUT} | - | 12 | 19 | mA |
| Current Limit | - | 151 | 300 | - | mA |

^{3.} Voltage range specified in Output Stage of the Electrical Characteristics in boldface type.

Measured to pin 16.
 Per IPC / JEDEC J-STD-020C.

^{*}During the voltage range which exceeds the maximum tested voltage of V_{IN}, operation is assured, but not specified. Wider limits may apply. Thermal dissipation must be observed closely.

 $\textbf{ELECTRICAL CHARACTERISTICS (continued)} \ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ on \ voltage \ option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, (Note \ 4); \\ \, (I_{OUT} = 1.0 \ mA; \ -40 ^{\circ}C \leq T_{J} \leq 150 ^{\circ}C; \ \, V_{IN} = dependent \ \, on \ \, voltage \ \, option \ \, voltage \ \, on \ \, on \ \, voltage \ \, on \ \, voltage \ \, on \ \, on \ \, on \ \, on \ \, o$ unless otherwise specified.)

| Characteristic | Test Conditions | Min | Тур | Max | Unit |
|---|---|--------------|----------------|--|------------------|
| Output Stage | | | | • | |
| Short Circuit Output Current | V _{OUT} = 0 V | 40 | 190 | - | mA |
| Thermal Shutdown | (Guaranteed by Design) | 150 | 180 | - | °C |
| Reset Function (RESET) | | | • | | |
| RESET Threshold for 2.5 V Option HIGH (V _{RH}) LOW (V _{RL}) | $5.5 \text{ V} \le V_{\text{IN}} \le 26 \text{ V (Note 5)}$ V_{OUT} Increasing V_{OUT} Decreasing | 2.28 2.25 | 2.350 2.300 | $0.98 \times V_{OUT}$ $0.97 \times V_{OUT}$ | V V |
| RESET Threshold for 3.3 V Option HIGH (V _{RH}) LOW (V _{RL}) | $5.5 \text{ V} \leq V_{\text{IN}} \leq 26 \text{ V (Note 5)}$ V_{OUT} Increasing V_{OUT} Decreasing | 3.00 2.97 | 3.102 3.036 | 0.98 × V _{OUT} 0.97 × V _{OUT} | V V |
| RESET Threshold for 5.0 V Option HIGH (V _{RH}) LOW (V _{RL}) | V _{OUT} Increasing V _{OUT} Decreasing | 4.55 4.50 | 4.70 4.60 | $0.98 \times V_{OUT}$ $0.97 \times V_{OUT}$ | V V |
| RESET Threshold for 8.0 V Option HIGH (V _{RH}) LOW (V _{RL}) | V _{OUT} Increasing V _{OUT} Decreasing | 7.05 7.00 | 7.52 7.36 | $0.98 \times V_{OUT}$ $0.97 \times V_{OUT}$ | > > |
| RESET Threshold for 10 V Option HIGH (V _{RH}) LOW (V _{RL}) | V _{OUT} Increasing V _{OUT} Decreasing | 8.60 8.50 | 9.40 9.20 | $0.98 \times V_{OUT}$ $0.97 \times V_{OUT}$ | V V |
| Output Voltage Low (V _{RLO}) | 1.0 V ≤ V _{OUT} ≤ V _{RL} , R _{RESET} = 10 k | - | 0.1 | 0.4 | V |
| DELAY Switching Threshold (V _{DT}) | - | 1.4 | 1.8 | 2.2 | V |
| DELAY Low Voltage | V _{OUT} < RESET Threshold Low(min) | - | - | 0.1 | V |
| DELAY Charge Current | DELAY = 1.0 V, V _{OUT} > V _{RH} | 1.5 | 2.5 | 3.5 | μΑ |
| DELAY Discharge Current | DELAY = 1.0 V, V _{OUT} = 1.5 V | 5.0 | - | - | mA |
| Reset Adjust Switching Voltage (V _{R(ADJ)}) | - | 1.23 | 1.31 | 1.39 | V |
| FLAG/Monitor | | | - | | |
| Monitor Threshold | Increasing and Decreasing | 1.10 | 1.20 | 1.31 | V |
| Hysteresis | - | 20 | 50 | 100 | mV |
| Input Current | MON = 2.0 V | -0.5 | 0.1 | 0.5 | μΑ |
| Output Saturation Voltage | MON = 0 V, I _{FLAG} = 1.0 mA | - | 0.1 | 0.4 | V |
| Voltage Adjust (Adjustable Output | only) | | - | | |
| Input Current | V _{ADJ} = 1.28 V | -0.5 | _ | 0.5 | μΑ |

Voltage range specified in Output Stage of the Electrical Characteristics in boldface type.
 For V_{IN} ≤ 5.5 V, a RESET = Low may occur with the output in regulation.

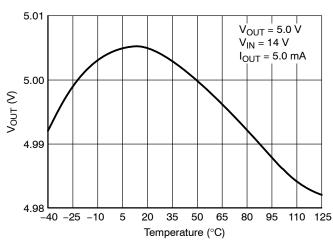
PACKAGE PIN DESCRIPTION, ADJUSTABLE OUTPUT

| Package I | Pin Number | | |
|---------------------------------|----------------------|------------------|--|
| SOW-16 SO-8 E PAD Pin Symbol | | Pin Symbol | Function |
| 1 | 7 | V_{IN} | Input Voltage. |
| 2 | 8 | MON | Monitor. Input for early warning comparator. If not needed connect to V _{OUT} . |
| 3, 4 | 3–6, 9–12, 14, 15 | NC | No connection. |
| 5 | 13 | GND | Ground. All GND leads must be connected to Ground |
| 6 | 16 | FLAG | Open collector output from early warning comparator. |
| 7 | 1 | V_{ADJ} | Voltage Adjust. A resistor divider from V _{OUT} to this lead sets the output voltage. |
| 8 | 2 | V _{OUT} | ±2.0%, 150 mA output. |

PACKAGE PIN DESCRIPTION, FIXED OUTPUT

| Package I | Pin Number | | |
|-----------|------------------------|------------------|--|
| SO-8 | SOW-16 E PAD | Pin Symbol | Function |
| 1 | 7 | V_{IN} | Input Voltage. |
| 2 | 8 | MON | Monitor. Input for early warning comparator. If not needed connect to V _{OUT} . |
| 3 | 9 | R _{ADJ} | Reset Adjust. If not needed connect to ground. |
| 4 | 10 | DELAY | Timing capacitor for RESET function. |
| 5 | 13 | GND | Ground. All GND leads must be connected to Ground |
| 6 | 16 | RESET | Active reset (accurate to V _{OUT} ≥ 1.0 V) |
| 7 | 1 | FLAG | Open collector output from early warning comparator. |
| 8 | 2 | V _{OUT} | ±2.0%, 150 mA output. |
| - | 3–6, 11, 12, 14, 15 | NC | No connection. |

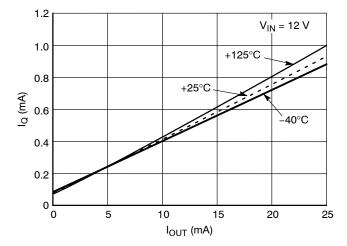
TYPICAL PERFORMANCE CHARACTERISTICS



3.35 $V_{OUT} = 3.3 \text{ V}$ V_{IN} = 14 V 3.34 $I_{OUT} = 5.0 \text{ mA}$ 3.33 3.32 V_{OUT} (V) 3.31 3.30 3.29 3.28 3.27 -40 -25 -10 5 95 110 125 20 35 50 65 80 Temperature (°C)

Figure 2. Output Voltage vs. Temperature

Figure 3. Output Voltage vs. Temperature



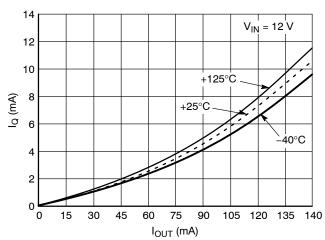
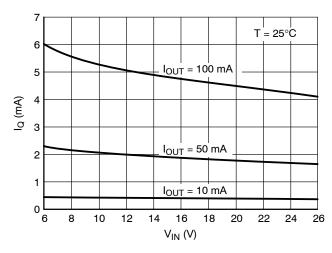


Figure 4. Quiescent Current vs. Output Current

Figure 5. Quiescent Current vs. Output Current



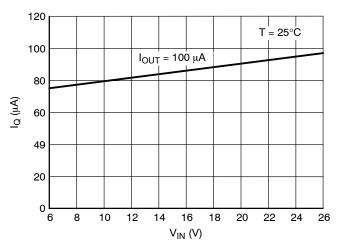
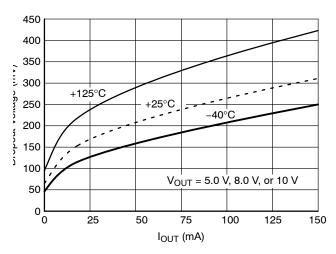


Figure 6. Quiescent Current vs. Input Voltage

Figure 7. Quiescent Current vs. Input Voltage

TYPICAL PERFORMANCE CHARACTERISTICS



1000 g Unstable Region 100 10 V (©) HS3 5 V 3.3 V Stable Region 0.1 $C_{VOUT} = 10 \; \mu F$ 0.01 0 30 50 60 70 90 10 20 40 100 **OUTPUT CURRENT (mA)**

Figure 8. Dropout Voltage vs. Output Current

Figure 9. Output Stability with Output Voltage Change

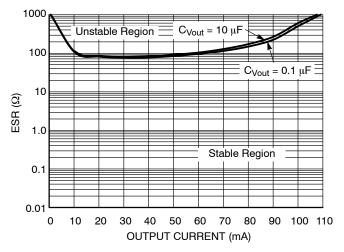


Figure 10. Output Stability with Output Capacitor Change

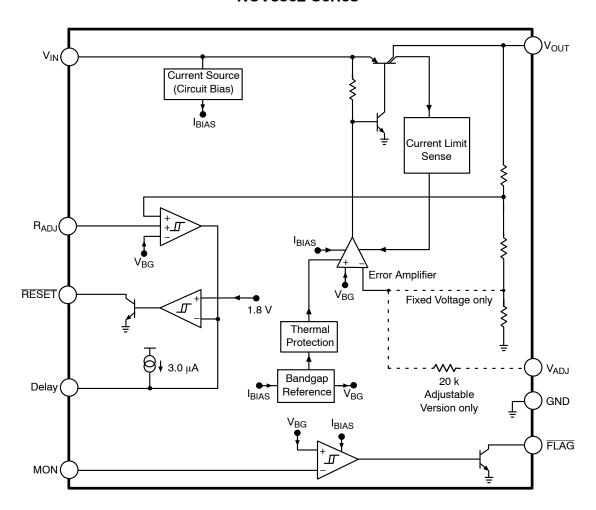


Figure 11. Block Diagram

CIRCUIT DESCRIPTION

REGULATOR CONTROL FUNCTIONS

The NCV8502 contains the microprocessor compatible control function \overline{RESET} (Figure 12).

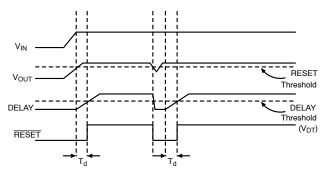


Figure 12. Reset and Delay Circuit Wave Forms

RESET Function

A \overline{RESET} signal (low voltage) is generated as the IC powers up until V_{OUT} is within 6.0% of the regulated output voltage, or when V_{OUT} drops out of regulation,and is lower than 8.0% below the regulated output voltage. Hysteresis is included in the function to minimize oscillations.

The \overline{RESET} output is an open collector NPN transistor, controlled by a low voltage detection circuit. The circuit is functionally independent of the rest of the IC thereby guaranteeing that the \overline{RESET} signal is valid for V_{OUT} as low as 1.0 V.

Adjustable Reset Function

The reset threshold can be made lower by connecting an external resistor divider to the R_{ADJ} lead from the V_{OUT} lead, as displayed in Figure 13. This lead is grounded to select the default value of 4.6 V.

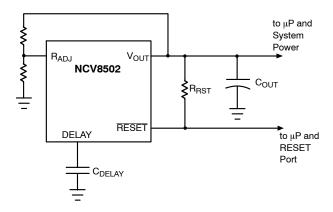


Figure 13. Adjustable RESET

DELAY Function

The reset delay circuit provides a programmable (by external capacitor) delay on the \overline{RESET} output lead.

The DELAY lead provides source current (typically 2.5 µA) to the external DELAY capacitor during the following proceedings:

- 1. During Power Up (once the regulation threshold has been verified).
- 2. After a reset event has occurred and the device is back in regulation. The DELAY capacitor is discharged when the regulation (RESET threshold) has been violated. This is a latched incident. The capacitor will fully discharge and wait for the device to regulate before going through the delay time event again.

FLAG/Monitor Function

An on-chip comparator is provided to perform an early warning to the microprocessor of a possible reset signal. The reset signal typically turns the microprocessor off instantaneously. This can cause unpredictable results with the microprocessor. The signal received from the FLAG pin will allow the microprocessor time to complete its present task before shutting down. This function is performed by a comparator referenced to the bandgap reference. The actual trip point can be programmed externally using a resistor divider to the input monitor (MON) (Figure 14). The typical threshold is 1.20 V on the MON pin.

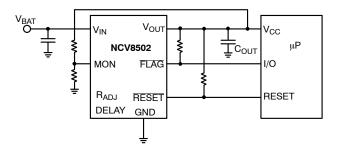


Figure 14. FLAG/Monitor Function

Voltage Adjust

Figure 15 shows the device setup for a user configurable output voltage. The feedback to the V_{ADJ} pin is taken from a voltage divider referenced to the output voltage. The loop is balanced around the Unity Gain threshold (1.28 V typical).

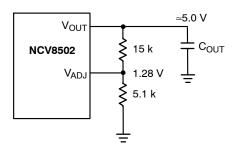


Figure 15. Adjustable Output Voltage

APPLICATION NOTES

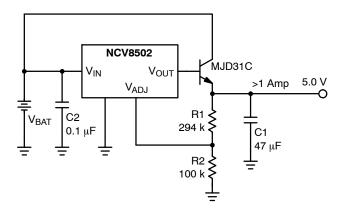


Figure 16. Additional Output Current

Adding Capability

Figure 16 shows how the adjustable version of parts can be used with an external pass transistor for additional current capability. The setup as shown will provide greater than 1 Amp of output current.

FLAG MONITOR

Figure 17 shows the FLAG Monitor waveforms as a result of the circuit depicted in Figure 14. As the output voltage falls (V_{OUT}), the Monitor threshold is crossed. This causes the voltage on the \overline{FLAG} output to go low sending a warning signal to the microprocessor that a \overline{RESET} signal may occur in a short period of time. $T_{WARNING}$ is the time the microprocessor has to complete the function it is currently working on and get ready for the \overline{RESET} shutdown signal.

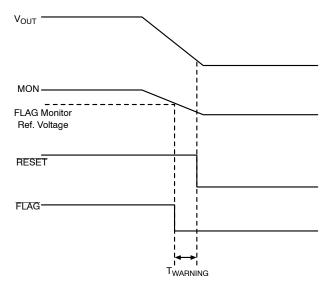
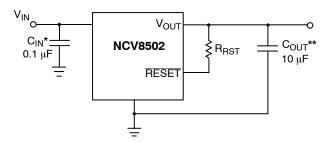


Figure 17. FLAG Monitor Circuit Waveform



*C_{IN} required if regulator is located far from the power supply filter
**C_{OUT} required for stability. Capacitor must operate at minimum
temperature expected

Figure 18. Test and Application Circuit Showing Output Compensation

SETTING THE DELAY TIME

The delay time is controlled by the Reset Delay Low Voltage, Delay Switching Threshold, and the Delay Charge Current. The delay follows the equation:

$$t_{DELAY} = \frac{\left[\text{CDELAY}(\text{V}_{dt} - \text{Reset Delay Low Voltage}) \right]}{\text{Delay Charge Current}}$$

Example:

Using $C_{DELAY} = 33 \text{ nF}$.

Assume reset Delay Low Voltage = 0.

Use the typical value for $V_{dt} = 1.8 \text{ V}$.

Use the typical value for Delay Charge Current = $2.5 \mu A$.

$$t_{DELAY} = \frac{\left[33 \text{ nF}(1.8 - 0)\right]}{2.5 \,\mu\text{A}} = 23.8 \text{ ms}$$

STABILITY CONSIDERATIONS

The output or compensation capacitor helps determine three main characteristics of a linear regulator: start-up delay, load transient response and loop stability.

The capacitor value and type should be based on cost, availability, size and temperature constraints.

The value for the output capacitor C_{OUT} shown in Figure 18 should work for most applications, however it is not necessarily the optimized solution.

CALCULATING POWER DISSIPATION IN A SINGLE OUTPUT LINEAR REGULATOR

The maximum power dissipation for a single output regulator (Figure 19) is:

$$PD(max) = [VIN(max) - VOUT(min)] IOUT(max) + VIN(max) IQ$$
(eq. 1)

where:

V_{IN(max)} is the maximum input voltage,

V_{OUT(min)} is the minimum output voltage,

 $I_{OUT(max)}$ is the maximum output current for the application, and

 I_Q is the quiescent current the regulator consumes at $I_{OUT(max)}$.

Once the value of $P_{D(max)}$ is known, the maximum permissible value of $R_{\theta JA}$ can be calculated:

$$R_{\Theta JA} = \frac{150^{\circ}C - T_{A}}{P_{D}}$$
 (eq. 2)

The value of $R_{\theta JA}$ can then be compared with those in the package section of the data sheet. Those packages with $R_{\theta JA}$'s less than the calculated value in equation 2 will keep the die temperature below 150°C.

In some cases, none of the packages will be sufficient to dissipate the heat generated by the IC, and an external heatsink will be required.

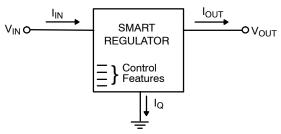


Figure 19. Single Output Regulator with Key Performance Parameters Labeled

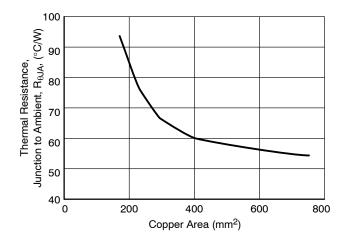


Figure 20. 16 Lead SOW (Exposed Pad), θJA as a Function of the Pad Copper Area (2 oz. Cu Thickness), Board Material = 0.0625" G-10/R-4

HEAT SINKS

A heat sink effectively increases the surface area of the package to improve the flow of heat away from the IC and into the surrounding air.

Each material in the heat flow path between the IC and the outside environment will have a thermal resistance. Like series electrical resistances, these resistances are summed to determine the value of $R_{\theta IA}$:

$$R_{\theta}JA = R_{\theta}JC + R_{\theta}CS + R_{\theta}SA$$
 (eq. 3)

where:

 $R_{\theta IC}$ = the junction-to-case thermal resistance,

 $R_{\theta CS}$ = the case-to-heatsink thermal resistance, and

 $R_{\theta SA}$ = the heatsink-to-ambient thermal resistance.

 $R_{\theta JC}$ appears in the package section of the data sheet. Like $R_{\theta JA}$, it too is a function of package type. $R_{\theta CS}$ and $R_{\theta SA}$ are functions of the package type, heatsink and the interface between them. These values appear in heat sink data sheets of heat sink manufacturers.

ORDERING INFORMATION

| Device | Output Voltage | Package | Shipping [†] |
|---------------|----------------|-------------------|-----------------------|
| NCV8502D50R2G | 5.0 V | SO-8 (Pb-Free) | 2500 Tape & Reel |

DISCONTINUED (Note 6)

| NCV8502DADJG | | SO-8 (Pb-Free) | 98 Units/Rail |
|------------------|------------|---------------------------------|------------------|
| NCV8502DADJR2G | | SO-8 (Pb-Free) | 2500 Tape & Reel |
| NCV8502PDWADJG | Adjustable | SOW-16 Exposed Pad (Pb-Free) | 47 Units/Rail |
| NCV8502PDWADJR2G | | SOW-16 Exposed Pad (Pb-Free) | 1000 Tape & Reel |
| NCV8502D25G | | SO-8 (Pb-Free) | 98 Units/Rail |
| NCV8502D25R2G | 2.5 V | SO-8 (Pb-Free) | 2500 Tape & Reel |
| NCV8502PDW25G | 2.5 V | SOW-16 Exposed Pad (Pb-Free) | 47 Units/Rail |
| NCV8502PDW25R2G | | SOW-16 Exposed Pad (Pb-Free) | 1000 Tape & Reel |
| NCV8502D33G | | SO-8 (Pb-Free) | 98 Units/Rail |
| NCV8502D33R2G | | SO-8 (Pb-Free) | 2500 Tape & Reel |
| NCV8502PDW33G | 3.3 V | SOW-16 Exposed Pad (Pb-Free) | 47 Units/Rail |
| NCV8502PDW33R2G | | SOW-16 Exposed Pad (Pb-Free) | 1000 Tape & Reel |
| NCV8502D50G | | SO-8 (Pb-Free) | 98 Units/Rail |
| NCV8502PDW50G | 5.0 V | SOW-16 Exposed Pad (Pb-Free) | 47 Units/Rail |
| NCV8502PDW50R2G | | SOW-16 Exposed Pad (Pb-Free) | 1000 Tape & Reel |
| NCV8502D80G | | SO-8 (Pb-Free) | 98 Units/Rail |
| NCV8502D80R2G | | SO-8 (Pb-Free) | 2500 Tape & Reel |
| NCV8502PDW80G | 8.0 V | SOW-16 Exposed Pad (Pb-Free) | 47 Units/Rail |
| NCV8502PDW80R2G | 1 | SOW-16 Exposed Pad (Pb-Free) | 1000 Tape & Reel |
| NCV8502D100G | | SO-8 (Pb-Free) | 98 Units/Rail |
| NCV8502D100R2G | 10 V | SO-8 (Pb-Free) | 2500 Tape & Reel |
| NCV8502PDW100G | | SOW-16 Exposed Pad (Pb-Free) | 47 Units/Rail |
| NCV8502PDW100R2G | | SOW-16 Exposed Pad (Pb-Free) | 1000 Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{6.} **DISCONTINUED:** These devices are not recommended for new design. Please contact your **onsemi** representative for information. The most current information on these devices may be available on www.onsemi.com.





SOIC-8 NB CASE 751-07 **ISSUE AK**

DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

| | MILLIMETERS | | INC | HES |
|-----|-------------|-------|-----------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 4.80 | 5.00 | 0.189 | 0.197 |
| В | 3.80 | 4.00 | 0.150 | 0.157 |
| С | 1.35 | 1.75 | 0.053 | 0.069 |
| D | 0.33 | 0.51 | 0.013 | 0.020 |
| G | 1.27 | 7 BSC | 0.050 BSC | |
| Н | 0.10 | 0.25 | 0.004 | 0.010 |
| J | 0.19 | 0.25 | 0.007 | 0.010 |
| K | 0.40 | 1.27 | 0.016 | 0.050 |
| М | 0 ° | 8 ° | 0 ° | 8 ° |
| N | 0.25 | 0.50 | 0.010 | 0.020 |
| S | 5.80 | 6.20 | 0.228 | 0.244 |

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot = Year = Work Week W

= Pb-Free Package

XXXXXX XXXXXX AYWW AYWW Ŧ \mathbb{H} Discrete **Discrete** (Pb-Free)

XXXXXX = Specific Device Code = Assembly Location Α = Year ww = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

| STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER | STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1 | STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1 | STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE |
|--|---|---|---|
| STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE | STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE | STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd | STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE. #1 |
| STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON | STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND | STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1 | STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN |
| STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN | STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN | STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON | STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 7. COLLECTOR, DIE #2 8. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1 |
| STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC | STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE | STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1 | STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN |
| STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6 | STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND | STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT | STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE |
| STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT | STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC | STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN | STYLE 28: PIN 1. SW TO GND 2. DASIC OFF 3. DASIC SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN |
| STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1 | STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1 | | |

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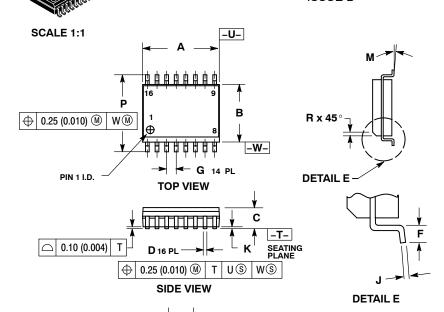
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CASE 751AG ISSUE B

DATE 31 MAY 2016

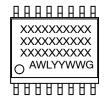


NOTES: 1. DIN

- . DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982.
- Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER.
- 3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- 5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 (0.06) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. 751R-01 OBSOLETE, NEW STANDARD 751R-02.

| | MILLIMETERS | | INCHES | |
|-----|-------------|-------|-----------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 10.15 | 10.45 | 0.400 | 0.411 |
| В | 7.40 | 7.60 | 0.292 | 0.299 |
| С | 2.35 | 2.65 | 0.093 | 0.104 |
| D | 0.35 | 0.49 | 0.014 | 0.019 |
| F | 0.50 | 0.90 | 0.020 | 0.035 |
| G | 1.27 BSC | | 0.050 BSC | |
| Н | 3.45 | 3.66 | 0.136 | 0.144 |
| J | 0.25 | 0.32 | 0.010 | 0.012 |
| K | 0.00 | 0.10 | 0.000 | 0.004 |
| L | 4.72 | 4.93 | 0.186 | 0.194 |
| M | 0 ° | 7 ° | 0 ° | 7 ° |
| P | 10.05 | 10.55 | 0.395 | 0.415 |
| R | 0.25 | 0.75 | 0.010 | 0.029 |

GENERIC MARKING DIAGRAM*



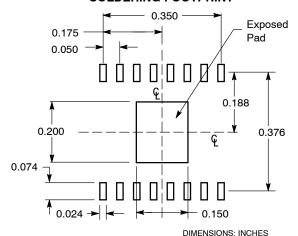
XXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot
 YY = Year
 WW = Work Week
 G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " ■", may or may not be present.

BOTTOM VIEW SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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